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(54) Title: MECHANISM FOR PEAK POWER MANAGEMENT IN A MEMORY

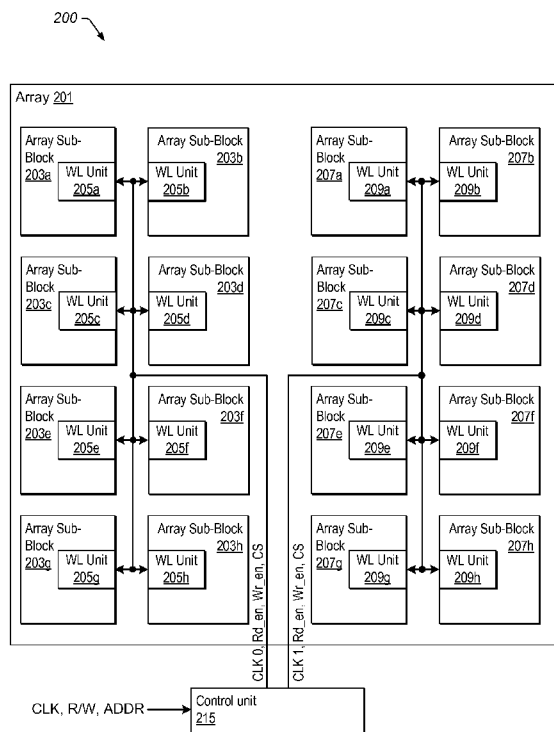


FIG. 2

(57) Abstract: A mechanism for managing peak power in a memory storage array that includes sub-array blocks may reduce the peak currents associated with read and write operations by staggering the wordline signal activation to each of the sub-array blocks. In particular, the wordline units within each sub-array block may generate the wordline signals to each sub-array block such that a read wordline signal of one sub-array block does not transition from one logic level to another logic level at the same time as the write wordline of another sub-array block. Further, the wordline units may generate the wordline signals to each sub-array block such that a read wordline of a given sub-array block does not transition from one logic level to another logic level at the same time as a read wordline signal of another sub-array block.



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TITLE: MECHANISM FOR PEAK POWER MANAGEMENT IN A MEMORY**BACKGROUND**

Technical Field

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[0001] This disclosure relates to memories, and more particularly to peak power reduction.

Description of the Related Art

10 **[0002]** Many devices include embedded memories and/or onboard memories. In many such devices, these memories may take up a significant portion of the integrated circuit die. Accordingly, these memories can consume a great deal of power. However, rather than average power consumed, in some cases peak power can be problematic because surges or large peaks in current usage can cause voltage sags on the main Vdd supply. These voltage sags can cause
15 improper operation of not only the memory, but also other circuits connected to the supply.

SUMMARY OF THE EMBODIMENTS

[0003] Various embodiments of a mechanism for managing peak power in a memory are disclosed. Broadly speaking, a mechanism for managing peak power in a memory storage array
20 is contemplated. In a memory that includes many sub-array blocks, it may be possible to reduce the peak currents associated with read and write operations by staggering the wordline signal activation to each of the sub-array blocks. In particular, the wordline units may be configured to generate the wordline signals to each sub-array block such that a read wordline signal of one sub-array block does not transition from one logic level to another logic level at the same time as
25 the write wordline of another sub-array block. Further, the wordline units may be configured to generate the wordline signals to each sub-array block such that a read wordline of a given sub-array block does not transition from one logic level to another logic level at the same time as a read wordline signal of another sub-array block.

30 **[0004]** In one embodiment, a memory includes a storage array including a number of sub-array blocks and each sub-array block includes a wordline driver unit. Each wordline driver unit may generate a read wordline signal to initiate a read operation and a write wordline signal to

initiate a write operation such that the read wordline signal of a given wordline driver unit and the write word line of a different wordline driver unit do not transition from one logic level to another logic level at a same time.

- 5 [0005] In one specific implementation, each wordline driver unit may further generate the read wordline signal such that no read wordline signals transition from one logic level to another logic level at the same time.

BRIEF DESCRIPTION OF THE DRAWINGS

- 10 [0006] FIG. 1 is a block diagram of a processor.

[0007] FIG. 2 is a block diagram of one embodiment of a portion of a memory including a mechanism to reduce peak power.

- 15 [0008] FIG. 3 is a timing diagram describing operational aspects of the embodiment of the memory of FIG. 2.

[0009] FIG. 4 is a timing diagram describing additional operational aspects of the embodiment of the memory of FIG. 2.

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[0010] FIG. 5 is a block diagram of one embodiment of a system.

- [0011] Specific embodiments are shown by way of example in the drawings and will herein be described in detail. It should be understood, however, that the drawings and detailed
25 description are not intended to limit the claims to the particular embodiments disclosed, even where only a single embodiment is described with respect to a particular feature. On the contrary, the intention is to cover all modifications, equivalents and alternatives that would be apparent to a person skilled in the art having the benefit of this disclosure. Examples of features provided in the disclosure are intended to be illustrative rather than restrictive unless stated
30 otherwise.

[0012] As used throughout this application, the word “may” is used in a permissive sense (i.e., meaning having the potential to), rather than the mandatory sense (i.e., meaning must). Similarly, the words “include,” “including,” and “includes” mean including, but not limited to.

5 [0013] Various units, circuits, or other components may be described as “configured to” perform a task or tasks. In such contexts, “configured to” is a broad recitation of structure generally meaning “having circuitry that” performs the task or tasks during operation. As such, the unit/circuit/component can be configured to perform the task even when the unit/circuit/component is not currently on. In general, the circuitry that forms the structure
10 corresponding to “configured to” may include hardware circuits. Similarly, various units/circuits/components may be described as performing a task or tasks, for convenience in the description. Such descriptions should be interpreted as including the phrase “configured to.” Reciting a unit/circuit/component that is configured to perform one or more tasks is expressly intended not to invoke 35 U.S.C. § 112, paragraph six, interpretation for that
15 unit/circuit/component.

[0014] The scope of the present disclosure includes any feature or combination of features disclosed herein (either explicitly or implicitly), or any generalization thereof, whether or not it mitigates any or all of the problems addressed herein. Accordingly, new claims may be
20 formulated during prosecution of this application (or an application claiming priority thereto) to any such combination of features. In particular, with reference to the appended claims, features from dependent claims may be combined with those of the independent claims and features from respective independent claims may be combined in any appropriate manner and not merely in the specific combinations enumerated in the appended claims.

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DETAILED DESCRIPTION

[0015] Turning now to FIG. 1, a block diagram of one embodiment of a processor is shown. The processor 10 includes an instruction cache (ICache) 14 that is coupled to a fetch control unit 12. The processor also includes a decode unit 16 that is coupled to the fetch control unit 12 and
30 to a register file 22, which is in turn coupled to an execution core 24. The execution core 24 is coupled to an interface unit 34, which may be coupled to an external interface of the processor

10, as desired. It is noted that components having a reference designator that includes both a number and a letter may be referred to using only the number where appropriate for simplicity.

[0016] In one embodiment, the fetch control unit 12 is configured to provide a program counter address (PC) for fetching from the instruction cache 14. The instruction cache 14 is configured to provide instructions (with PCs) back to the fetch control unit 12 to be fed into the decode unit 16. The decode unit 16 may generally be configured to decode the instructions into instruction operations (ops) and to provide the decoded ops to the execution core 24. The decode unit 16 may also provide decoded operands to the register file 22, which may provide operands to the execution core 24. The decode unit 16 may also be configured to schedule each instruction and provide the correct register values for execution core 24 to use.

[0017] The register file 22 may also receive results from execution core 24 that are to be written into the register file 22. Accordingly, the register file 22 may generally include any set of registers usable to store operands and results. Thus, the register file 22 may be implemented using a variety of storage types such as flip-flop type storages, random access memory (RAM), and the like.

[0018] The instruction cache 14 may include control logic and memory arrays. The memory arrays may be used to store the cached instructions to be executed by processor 10 and the associated cache tags. Instruction cache 14 may have any capacity and construction (e.g. direct mapped, set associative, fully associative, etc.). Instruction cache 14 may include any cache line size.

[0019] It is contemplated that the processor 10 may implement any suitable instruction set architecture (ISA), such as ARM™, PowerPC™, or x86 ISAs, combinations thereof, etc. In some embodiments, the processor 10 may implement an address translation scheme in which one or more virtual address spaces are made visible to executing software. Memory accesses within the virtual address space are translated to a physical address space corresponding to the actual physical memory available to the system, for example using a set of page tables, segments, or other virtual memory translation schemes. In embodiments that employ address translation,

processor 10 may store a set of recent and/or frequently used virtual-to-physical address translations in a translation lookaside buffer (TLB), such as instruction TLB (ITLB) 30.

[0020] The execution core 24 may perform the various operations (e.g., MOV, ADD, SHIFT, LOAD, STORE, etc.) indicated by each instruction. In the illustrated embodiment, the execution core 24 includes data cache 26, which may be a cache memory for storing data to be processed by the processor 10. Like instruction cache 14, data cache 26 may have any suitable capacity, construction, or line size (e.g. direct mapped, set associative, fully associative, etc.). Moreover, data cache 26 may differ from the instruction cache 14 in any of these details. As with instruction cache 14, in some embodiments, data cache 26 may be partially or entirely addressed using physical address bits. Correspondingly, data TLB (DTLB) 32 may be provided to cache virtual-to-physical address translations for use in accessing data cache 26 in a manner similar to that described above with respect to ITLB 30. It is noted that although ITLB 30 and DTLB 32 may perform similar functions, in various embodiments they may be implemented differently. For example, they may store different numbers of translations and/or different translation information.

[0021] Interface unit 34 may generally include the circuitry for interfacing processor 10 to other devices on the external interface. The external interface may include any type of interconnect (e.g. bus, packet, etc.). The external interface may be an on-chip interconnect, if processor 10 is integrated with one or more other components (e.g. a system on a chip configuration). The external interface may be an off-chip interconnect to external circuitry, if processor 10 is not integrated with other components. In various embodiments, processor 10 may implement any instruction set architecture.

[0022] It is noted that each of the memories embedded within processor 10 (e.g., instruction cache 14, data cache 26, register file 22, etc.) may include wordline driver circuits to access their respective memory arrays. As described in greater detail below in conjunction with the description of FIG. 2, it may be possible to reduce the peak power associated with accessing the memory arrays of the embedded memories of processor 10 through the management of the wordline signals.

[0023] Referring to FIG. 2, a block diagram of one embodiment of a portion of a memory including a mechanism to reduce peak power is shown. The memory 200 includes an array 201 that is coupled to a control unit 215. It is noted that a number of features have been omitted from the drawings for the sake of brevity. For example, each of the sub-array blocks of FIG. 2 may include bit cells and bit lines (both not shown) for conveying and storing the read and write data.

[0024] In the illustrated embodiment, the array 201 includes several sub-array blocks (e.g., 203a through 203h and 205a through 207h). Each sub-array block includes respective a wordline driver unit (e.g., 205a through 205h and 209a through 209h), and a number of bit cells (not shown) to store the data. In addition, in one embodiment, the sub-array blocks are arranged into groups. In the illustrated embodiment, the sub-array blocks have been arranged such that blocks 203 form one group and blocks 205 form another group. Further, in one embodiment, a group of sub-array blocks (e.g., 203a-203h or 207a-207h) may be read or written but not both concurrently. In other words, if any of the sub-array blocks in a group are being read, then none of the sub-array blocks in that group may be written concurrent with the read operation. However, one group may be read while the other group is concurrently being written. In addition, in one embodiment, different sub-array blocks within the same group may be read concurrently, or written concurrently. For example, a read operation or a write operation may be performed to both sub-array block 203a and sub-array block 203h concurrently, but a write to sub-array block 203h while sub-array block 203a is being read would be prohibited.

[0025] Accordingly, the control unit 215 provides a separate set of control signals to each group of sub-array blocks. Specifically, in one embodiment, the control unit 215 may be configured to receive a clock signal (e.g., CLK), address information (e.g., ADDR), and read/write signals (e.g., R/W). The control unit 215 may provide two separate clock signals (e.g., CLK0 and CLK1) to the separate groups. For example, the CLK0 signal is provided to the group on the left (e.g., sub-array blocks 203a-203h), while the CLK1 signal is provided to the group on the right (e.g., sub-array blocks 207a-207h). The control unit 215 may also decode the ADDR information into one or more chip selects (e.g., CS) that may select which of the sub-array blocks will be accessed. The R/W signal may be decoded to produce a read enable or a write enable depending on whether it is a read access or a write access. In one embodiment, the

CLK0 and CLK1 signals may be combined with the Wr_en and the Rd_en signals within each wordline unit 205 and 207 to generate a write wordline signal and a read wordline signal, respectively, to access the bit cells (not shown) in the sub-array blocks.

5 [0026] In one embodiment, to reduce the peak current and thus the peak power consumed during memory accesses, the concurrent reads and writes to the sub-array blocks may be staggered so that the edges of the wordline signals are not aligned in time. Accordingly, as shown in FIG. 3, the read wordline and the write wordline are staggered.

10 [0027] Turning to FIG. 3, a timing diagram depicting operational aspects of the embodiment of the memory of FIG. 2 is shown. The timing diagram of FIG. 3 includes a clock signal (e.g., CLK(0,1) which may correspond to the CLK0 and/or the CLK 1 signal of FIG. 2. In addition, the timing diagram includes a read wordline signal (e.g., Rd WL) and a write wordline signal (e.g., Wr WL).

15 [0028] In the illustrated embodiment, both the Rd WL and the Wr WL may be initiated by the leading edge of the CLK0, 1 signal which occurs at time t_0 and as indicated by the wavy arrows. In addition, the falling edge of the Wr WL is also initiated by the falling edge of the CLK0, 1 signal, also indicated by a wavy arrow. Accordingly, the Wr WL duration is frequency
20 dependent. However, as shown, the falling edge of the Rd WL is not initiated by the falling edge of the CLK0, 1 signal. Instead, in one embodiment, the falling edge, at time t_3 , of the Rd WL may be based upon some predetermined amount of time after the rising edge of the Rd WL as indicated by the Δt . Thus, the Rd WL duration is frequency independent.

25 [0029] As shown in FIG. 3, the rising edge of the Rd WL begins at time t_1 , which may correspond to a small delay after the rising edge of the CLK0, 1 signal. In contrast, the rising edge of the Wr WL begins at time t_2 , which may be a significantly longer delay than the Rd WL delay since write operations occur quickly in comparison to read operations.

30 [0030] In the illustrated embodiment, the falling edge of the Rd WL may be adjustable as indicated by the dashed lines, dependent upon a number of factors such as sense amplifier type, bit line capacitance, operating voltage, etc. More particularly, in various embodiments, any of a

variety of timing circuits may be used to determine when the Rd WL falling edge will begin. For example, as a timer circuit, a wordline kill circuit or some other type of timing circuit may be used.

5 [0031] Further, in one embodiment, the delays associated with the rising edges of the Rd WL and the Wr WL may be implemented using gate delays within the WL units of FIG. 2. For example, within each WL unit 205 and 209 one or more logic gates such as inverters, buffers, or the like may be daisy chained to provide an appropriate delay for the respective wordline signal. In one embodiment, the CLK0 or CLK1 signal may be delayed internally at each WL unit 205
10 and 209, while in other embodiments the Rd_en or Wr_en may be delayed.

[0032] As mentioned above and described further below, each Rd WL and each Wr WL may also be staggered with respect to each other WL unit. In one embodiment, the leading or rising edges may be staggered, while in another embodiment the trailing edges may be staggered, and
15 in yet other embodiments, both the leading and trailing edges may be staggered. An exemplary timing diagram depicting such a staggered wordline arrangement is shown in FIG. 4.

[0033] Referring to FIG. 4, a timing diagram depicting additional operational aspects of the embodiment of the memory of FIG. 2 is shown. Similar to the timing diagram shown in FIG. 3,
20 the timing diagram of FIG also shows a clock signal (e.g., CLK(0,1) which may correspond to CLK0 and/or CLK 1 signals of FIG. 2. However in contrast to FIG. 3, the timing diagram of FIG. 4 includes multiple read wordline signals (e.g., Rd WL_a - WL_h), and multiple write wordline signals (e.g., Wr WL_a - WL_h), which may be representative of the wordline signals provided by the WL units 205 and 209 of FIG. 2.

25 [0034] As shown in FIG. 4, all of the Rd WL signal leading edges and all of the Wr WL signal leading edges are triggered by the CLK (0,1) signal which occurs at time t_0 . In addition, in one embodiment, each of the Rd WL signal leading edges is staggered relative to one another such that none of the Rd WL leading edges are aligned. For example, Rd WL_a is initiated at time
30 t_1 and Rd WL_b is initiated at time t_2 , and so forth. Similarly, each of the Wr WL signal leading edges is staggered relative to one another such that none of the Wr WL leading edges are

aligned. For example, Wr WL_a is initiated at time t₃ and Wr WL_b is initiated at time t₄, and so forth.

[0035] Further, similar to the falling edges described above in conjunction with the description of FIG. 3, the falling edges of the Wr WL_a - WL_h are also initiated by the falling edge of the CLK0, 1 signal, and the Rd WL_a - WL_h falling edges such as that shown at time t₅ may be adjustable as indicated by the dashed lines, and based upon some predetermined amount of time after the rising edge of the Rd WL as indicated by the Δt .

[0036] Turning to FIG. 5, a block diagram of one embodiment of a system is shown. The system 500 includes at least one instance of an integrated circuit 510 coupled to one or more peripherals 507 and an external system memory 505. The system 500 also includes a power supply 501 that may provide one or more supply voltages to the integrated circuit 510 as well as one or more supply voltages to the memory 505 and/or the peripherals 507.

[0037] In one embodiment, the integrated circuit 510 may be a system on a chip (SOC) including one or more instances of a processor such as processor 10 of FIG. 1, and various other circuitry such as a memory controller, video and/or audio processing circuitry, on-chip peripherals and/or peripheral interfaces to couple to off-chip peripherals, etc. Accordingly, the integrated circuit 510 may include one or more instances of an embedded memory such as memory 200 of FIG. 2. Thus, embodiments that include the memory 200 may also include WL units that stagger read and write wordline signals as described above in conjunction with the description of FIG. 2 through FIG. 4.

[0038] The peripherals 507 may include any desired circuitry, depending on the type of system. For example, in one embodiment, the system 500 may be included in a mobile device (e.g., personal digital assistant (PDA), smart phone, etc.) and the peripherals 507 may include devices for various types of wireless communication, such as WiFi, Bluetooth, cellular, global positioning system, etc. The peripherals 507 may also include additional storage, including various types of RAM storage, solid-state storage, or disk storage. As such, the peripherals 507 may also include RAM that includes the WL units described above. The peripherals 507 may include user interface devices such as a display screen, including touch display screens or

multitouch display screens, keyboard or other input devices, microphones, speakers, etc. In other embodiments, the system 500 may be included in any type of computing system (e.g. desktop personal computer, laptop, workstation, net top etc.).

5 **[0039]** The external system memory 505 may be representative of any type of memory. For example, the external memory 505 may be in the DRAM family such as synchronous DRAM (SDRAM), double data rate (DDR, DDR2, DDR3, etc.), or any low power version thereof. However, external memory 505 may also be implemented in SDRAM, static RAM (SRAM), or other types of RAM, etc. Accordingly, external system memory 505 may also include WL units
10 as described above in conjunction with the description of FIG. 2 through FIG. 4.

[0040] Although the embodiments above have been described in considerable detail, numerous variations and modifications will become apparent to those skilled in the art once the above disclosure is fully appreciated. It is intended that the following claims be interpreted to
15 embrace all such variations and modifications.

WHAT IS CLAIMED IS:

1. A memory (200) comprising:

a storage array (201) including a plurality of sub-array blocks (203, 207);

wherein each of the sub-array blocks includes a wordline driver unit (205, 209)

configured to generate a read wordline signal to initiate a read operation and a write wordline signal to initiate a write operation such that the read wordline signal of a given wordline driver unit and the write word line of a different wordline driver unit do not transition from one logic level to another logic level at a same time.

2. The memory as recited in claim 1, wherein each wordline driver unit is further configured to generate the read wordline signal such that no read wordline signals transition from one logic level to another logic level at the same time.

3. The memory as recited in claim 1, wherein each wordline driver unit is further configured to generate the write wordline signal such that no write wordline signals transition from one logic level to another logic level at the same time.

4. The memory as recited in claim 1, wherein each wordline driver unit is further configured to generate the read wordline signal and the write wordline signal such that a rising edge of the read wordline signal of a given wordline driver unit and a rising edge of the write wordline signal of the different wordline driver unit do not transition from one logic level to another logic level at the same time.

5. The memory as recited in claim 1, wherein each wordline driver unit is further configured to generate the read wordline signal and the write wordline signal such that a falling edge of the read wordline signal of a given wordline driver unit and a falling edge of the write wordline signal of the different wordline driver unit do not transition from one logic level to another logic level at the same time.

6. The memory as recited in claim 1, wherein each wordline driver unit is further configured to cause a falling edge of the read wordline signal to transition after a predetermined amount of time.

7. The memory as recited in claim 1, wherein each wordline driver unit is further configured to cause a falling edge of the write wordline signal to transition in response to a falling edge of a clock signal.

8. A system (500) comprising:

a memory (200); and

one or more processors (10) coupled to the memory, wherein at least one of the one or more processors includes an embedded memory (14, 22, 26);

wherein the embedded memory includes:

a storage array (201) including a plurality of sub-array blocks (203, 207);

wherein each of the sub-array blocks includes a wordline driver unit (205, 209)

configured to generate a read wordline signal to initiate a read operation and a write wordline signal to initiate a write operation such that the read wordline signal of a given wordline driver unit does not transition from one logic level to another logic level at a same time as the write word line of a different wordline driver unit.

9. The system as recited in claim 8, wherein each wordline driver unit is further configured to generate the read wordline signal and the write wordline signal such that a rising edge of the read wordline signal of a given wordline driver unit does not transition from one logic level to another logic level at the same time as a rising edge of the write wordline signal of the different wordline driver unit.

10. The system as recited in claim 8, wherein each wordline driver unit is further configured to cause a falling edge of the read wordline signal to transition after a predetermined amount of time.

11. The system as recited in claim 8, wherein each wordline driver unit is further configured to generate the read wordline signal and the write wordline signal such that a falling edge of the read wordline signal of a given wordline driver unit does not transition from one logic level to another logic level at the same time as a falling edge of the write wordline signal of the different wordline driver unit.

12. The system as recited in claim 8, wherein each wordline driver unit is further configured to cause a falling edge of the write wordline signal to transition in response to a falling edge of a clock signal.

13. A mobile communication device comprising:
a memory (505); and
a processor (10) coupled to the memory, wherein the processor includes an embedded memory (14, 22, 26) including:
a storage array (201) including a plurality of sub-array blocks (203, 207);
wherein each of the sub-array blocks includes a wordline driver unit (205, 209) configured to generate a read wordline signal to initiate a read operation and a write wordline signal to initiate a write operation such that the read wordline signal of a given wordline driver unit does not transition from one logic level to another logic level at a same time as the write word line of a different wordline driver unit.

14. The mobile communication device as recited in claim 13, wherein each wordline driver unit is further configured to generate the read wordline signal such that a rising edge of the read wordline signal of a given wordline driver unit does not transition from one logic level to another logic level at the same time as a rising edge of the read wordline signal of any other wordline driver unit.

15. The mobile communication device as recited in claim 13, wherein each wordline driver unit is further configured to generate the write wordline signal such that a rising edge of the write wordline signal of a given wordline driver unit does not transition from one logic level to

another logic level at the same time as a rising edge of the write wordline signal of any other wordline driver unit.

16. The mobile communication device as recited in claim 13, wherein each wordline driver unit is further configured to cause a falling edge of the write wordline signal to transition in response to a falling edge of a clock signal, and to cause a falling edge of the read wordline signal to transition after a predetermined amount of time.

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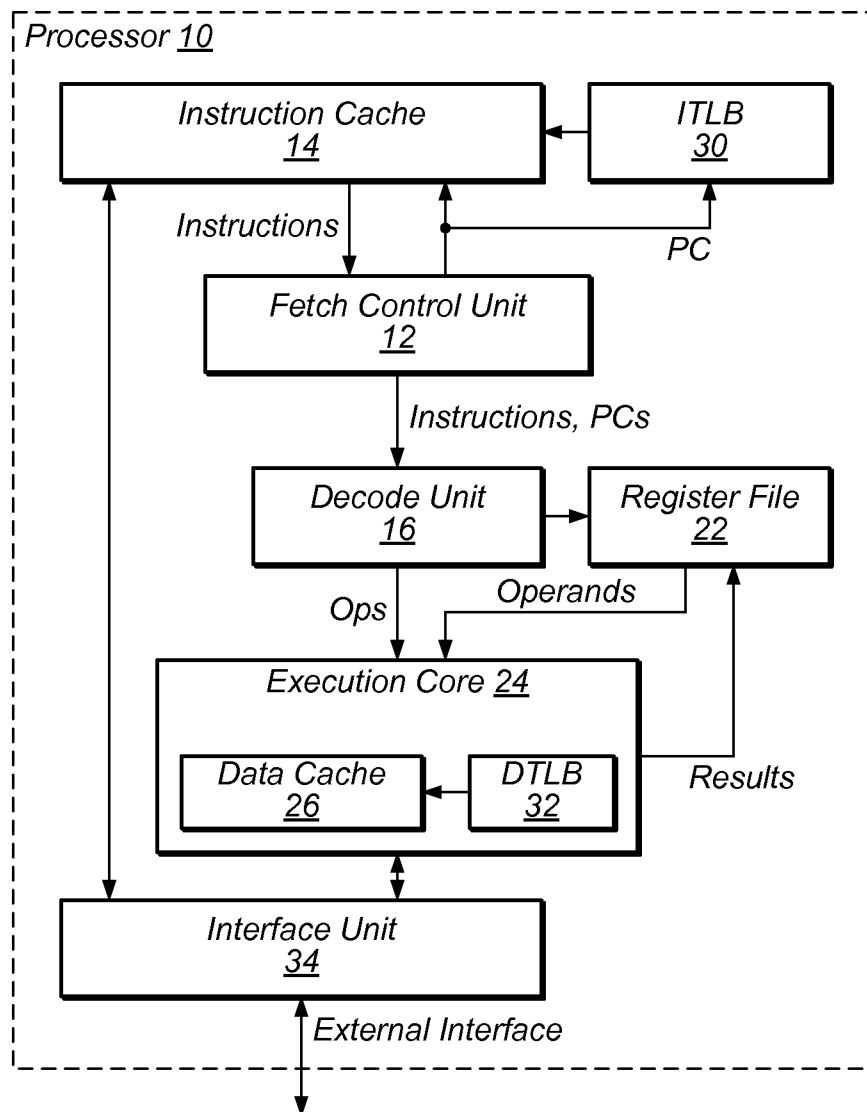


FIG. 1

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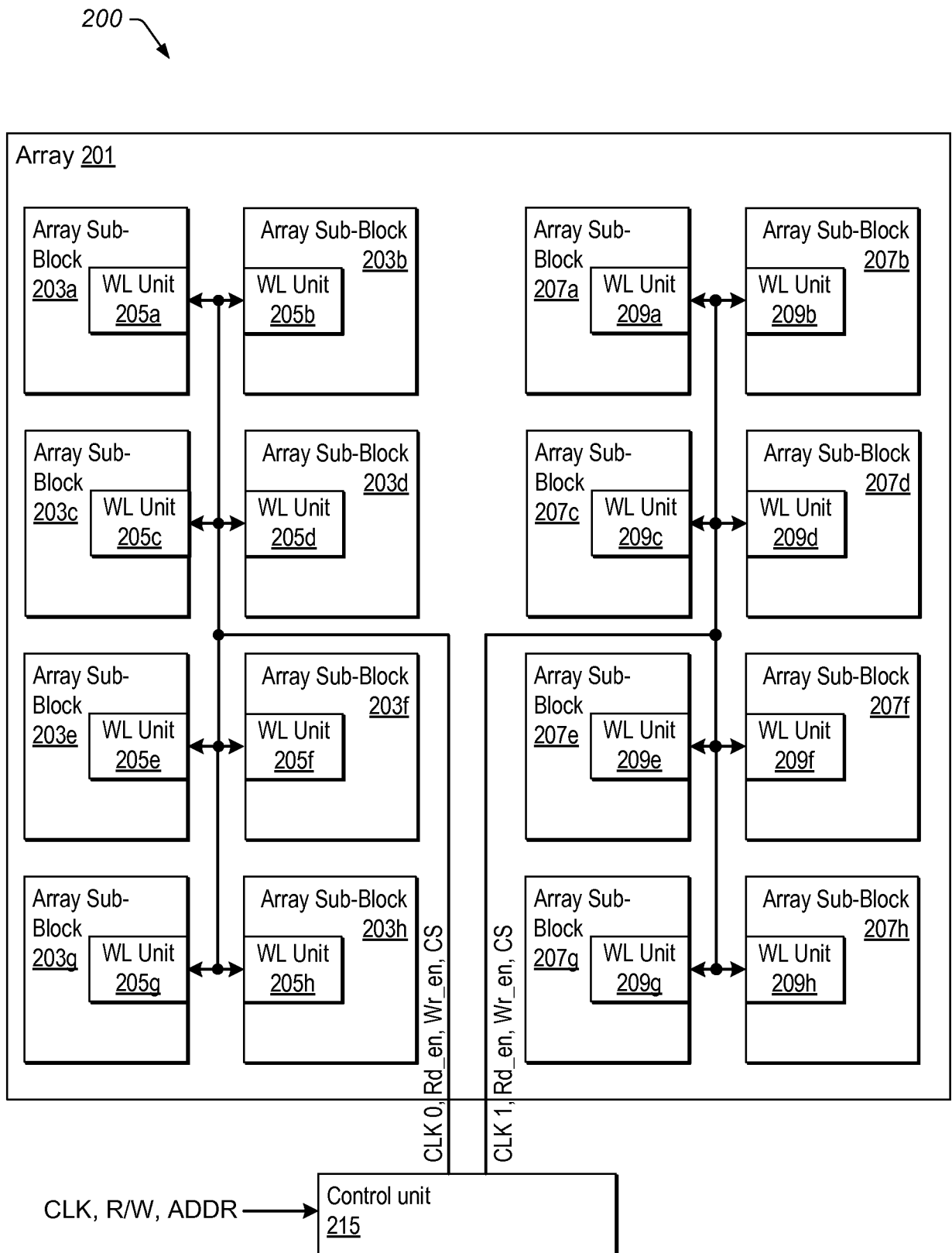


FIG. 2

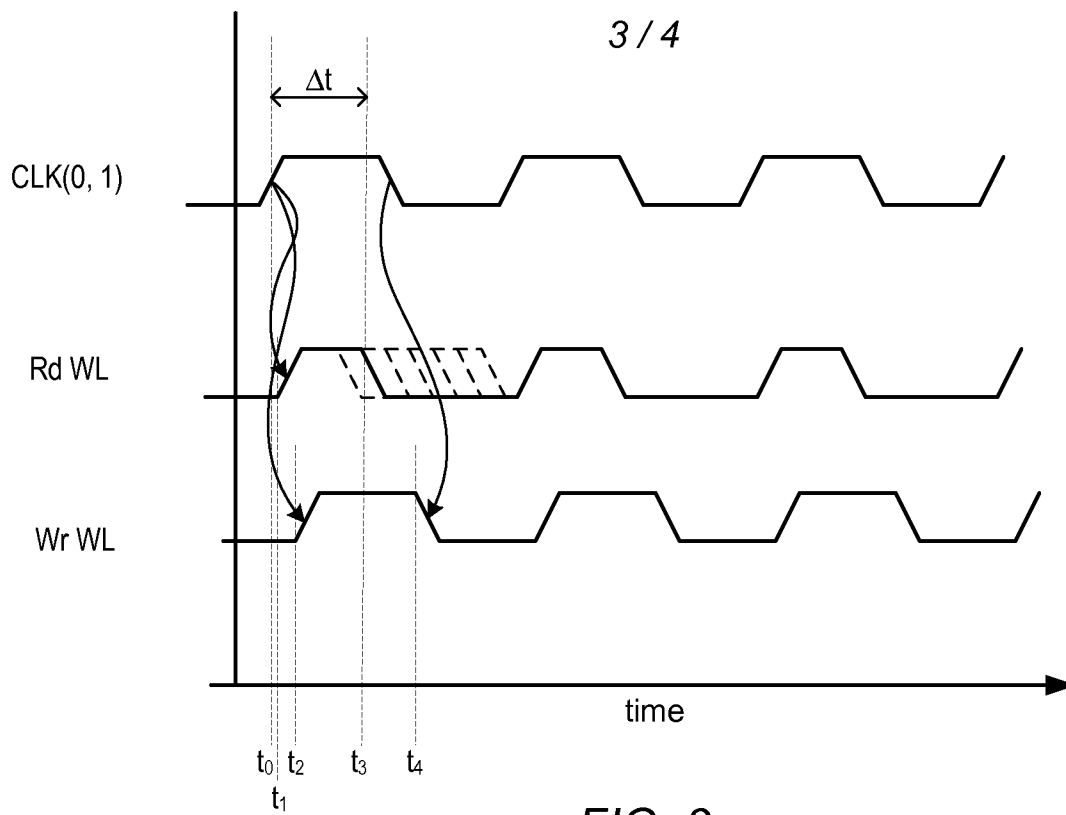


FIG. 3

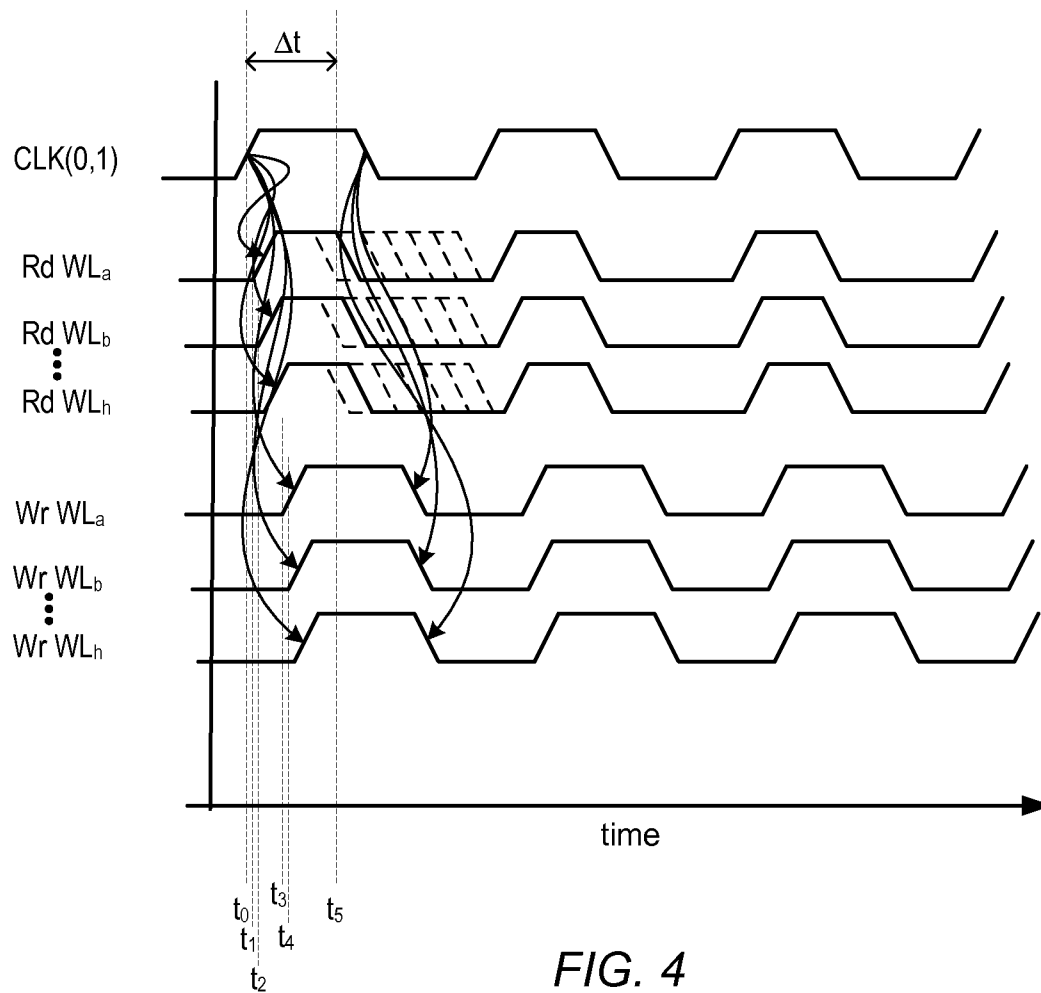


FIG. 4

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500

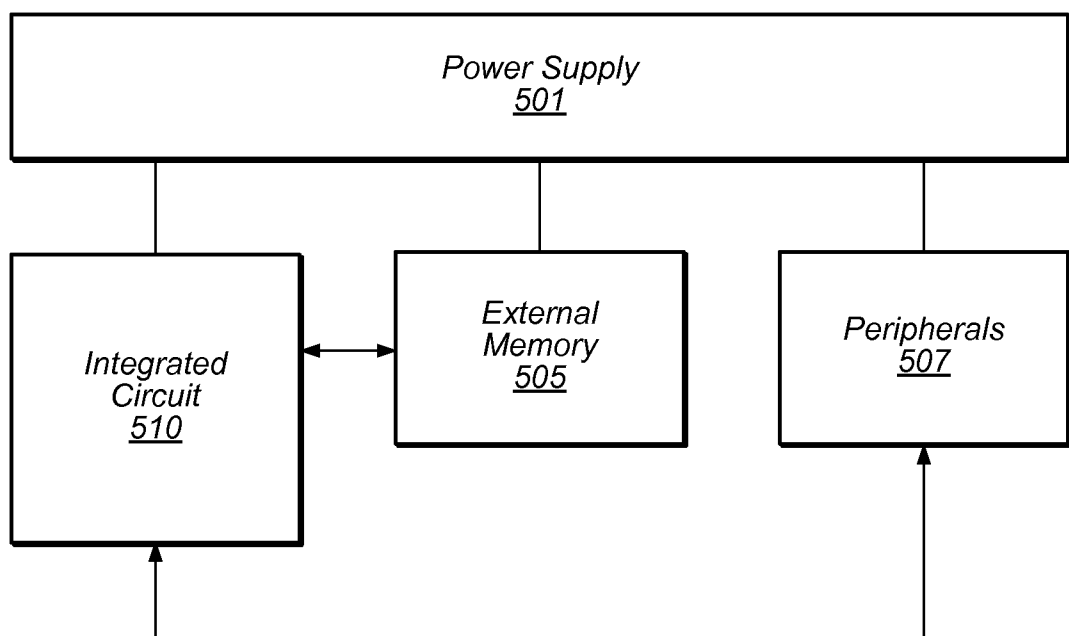


FIG. 5

INTERNATIONAL SEARCH REPORT

International application No.

PCT/US 12/52987

A. CLASSIFICATION OF SUBJECT MATTER

IPC(8) - G11C 5/14 (2012.01)

USPC - 365/226

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

IPC (8): G11C 5/14 (2012.01)

USPC: 365/226

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

USPC: 365/63, 149, 150, 189.011, 189.03, 189.18, 194, 222, 233.1, 228; 713/300, 322, 330, 340; 711/103, 104, 105, 167; 712/37, 38, (keyword limited - view terms below)

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

GooglePatents (patents), GoogleScholar (articles), Dialog (349 654 652 348 371 347 340); search terms: Memory, storage array, sub-array, wordline, driver unit, read wordline signal, read, write, logic level, rising edge, tock, falling edge, tick, processors, embedded memory, RAM, ROM, mobile communication, memory bank, data transfer rate, mobile ph

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
Y	US 5,590,086 A (PARK et al.) 31 December 1996 (31.12.1996) entire document, especially Abstract; col. 1, ln. 9-14; col. 2, ln. 10-12; col. 3, ln. 34-61; col. 9, ln. 44-50	1-16
Y	US 2002/0060949 A1 (KIM) 23 May 2002 (23.05.2002) entire document, especially Abstract; para. [0009]-[0011], [0013]	1-16
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☐ Further documents are listed in the continuation of Box C. ☐

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Date of the actual completion of the international search

13 October 2012 (13.10.2012)

Date of mailing of the international search report

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